

**Search Notes**

Application/Control No.

10/037,271

Examiner

Ren L. Yan

Applicant(s)/Patent under  
Reexamination

HUFFER, SCOTT W.

Art Unit

2854

**SEARCHED**

Class	Subclass	Date	Examiner
<i>search updated</i>		<i>3/30/06</i>	<i>R.Y.</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR